

Issue Classification



Application/Control No.
10650027

Applicant(s)/Patent under
Reexamination
BURBANK ET AL.

Examiner
Szmaj, Brian

Art Unit
3736

| ORIGINAL | | INTERNATIONAL CLASSIFICATION | | | | | | | | | | |
|---|----------|---|---|---|-------------|---------|-----------------------------------|--|--|--|--|--|
| CLASS | SUBCLASS | CLAIMED | | | NON-CLAIMED | | | | | | | |
| 600 | 569 | A | 6 | 1 | B | 10 / 00 | | | | | | |
| | | | | | | | | | | | | |
| | | | | | | | CROSS REFERENCE(S) | | | | | |
| | | | | | | | SUBCLASS (ONE SUBCLASS PER BLOCK) | | | | | |
| | | <div style="text-align: right;"> MAX F. HINDENBURG SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 3700 </div> | | | | | | | | | | |
| <div style="text-align: right;"> Ben Smith (Assistant Examiner) </div> | | <div style="text-align: right;"> 11-13-06 (Date) </div> | | | | | | | | | | |
| <div style="text-align: right;"> J. H. Jones (Legal Instruments Examiner) </div> | | <div style="text-align: right;"> 11/20/06 (Date) </div> | | | | | | | | | | |
| | | (Primary Examiner) | | | (Date) | | | | | | | |
| | | Total Claims Allowed: | | | 33 | | | | | | | |
| | | O.G. Print Claim(s) | | | 1 | | | | | | | |
| | | O.G. Print | | | 1 | | | | | | | |